Attorney's Docket No.: 05542-548002 / 005317D1/CMP

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Moshe Sarfaty et al. Art Unit: Unknown Serial No.: Unassigned Examiner: Unknown

Filed : July 10, 2003

Title : EDDY-OPTIC SENSOR FOR OBJECT INSPECTION

Mail Stop Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed.

Under 35 USC §120, this application relies on the earlier filing date of application serial number 09/812,329, filed on March 19, 2001. The following references were submitted to and/or cited by the Office in the prior application and, therefore, are not provided in this application:

Desig. IDs:

AA-AH

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 05542-548002	Application No. Unassigned
1	closure Statement pplicant	Applicant Moshe Sarfaty et al.	
(Use several s	heets if necessary)	Filing Date July 10, 2003	Group Art Unit Unknown

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	4,849,694	07/18/89	Coates			
	AB	4,963,500	10/16/90	Cogan et al.			
	AC	5,451,863	09/19/95	Freeman			
	AD	5,525,903	06/11/96	Mandl et al.			
	AE	5,640,242	06/17/97	O'Boyle et al.			
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	AG	5,929,994	07/27/99	Lee et al.			
	AH	6,034,781	03/07/00	Sarfaty et al.			
	AI						
	AJ						
	AK						
	AL						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AM					i		
	AN							
	AO							
	AP							
	AQ							

(Other Documents (include Author, Title, Date, and Place of Publication)					
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EXAMINER: Initials citation considered. Draw line through citation if no next communication to applicant.	t in conformance and not considered. Include copy of this form with